

Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient ^A	t ≤ 10s	D	31	40	C/W				
Maximum Junction-to-Ambient ^A	Steady State	$R_{ extsf{ heta}JA}$	59	75	C/W				
Maximum Junction-to-Lead ^C	Steady State	$R_{ extsf{ heta}JL}$	16	24	°C/W				

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV_{DSS}	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0 V$	40			V				
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 40V, V_{GS} = 0V$			1	μA				
		T _J = 55℃			5	μΑ				
I _{GSS}	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 20V$			±100	nA				
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS} I_D = 250 \mu A$	1.7	2.2	3	V				
I _{D(ON)}	On state drain current	$V_{GS} = 10V, V_{DS} = 5V$	120			А				
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 10V, I_D = 10A$		8.2	10					
		T _J =125℃		12.5	16	mΩ				
		$V_{GS} = 4.5V, I_{D} = 8A$		10	12.5]				
g fs	Forward Transconductance	$V_{DS} = 5V, I_{D} = 10A$		75		S				
V _{SD}	Diode Forward Voltage	$I_S = 1A, V_{GS} = 0V$		0.72	1	V				
I _S	Maximum Body-Diode Continuous Cur			2.5	А					
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance			1500	1950	pF				
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =20V, f=1MHz		215		pF				
C _{rss}	Reverse Transfer Capacitance			135		pF				
R _g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz	2	3.5	5	Ω				
SWITCHI	NG PARAMETERS									
Q _g (10V)	Total Gate Charge			27.2	37	nC				
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =20V, I _D =10A		13.6	18	nC				
Q _{gs}	Gate Source Charge	$v_{GS} = 100$, $v_{DS} = 200$, $v_{D} = 10A$		4.5		nC				
Q _{gd}	Gate Drain Charge			6.4		nC				
t _{D(on)}	Turn-On DelayTime			6.4		ns				
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =20V, R_{L} = 2 Ω ,		17.2		ns				
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		29.6		ns				
t _f	Turn-Off Fall Time	7		16.8		ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =10A, dl/dt=100A/µs		30	40	ns				
Q _{rr}	Body Diode Reverse Recovery Charge	, I _F =10A, dI/dt=100A/μs		19		nC				

Electrical Characteristics (T_J=25°C unless otherwise noted)

A: The value of R_{0JA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A = 25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\rm \theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm \theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using t \leqslant 300 μs pulses, duty cycle 0.5% max.

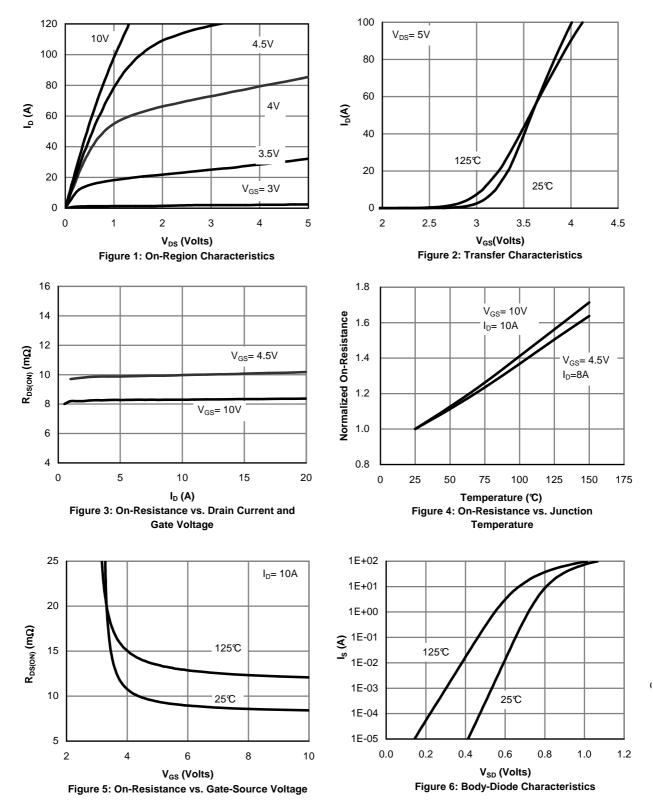
E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C. The SOA curve provides a single pulse rating.

F. The current rating is based on the t \leqslant 10s thermal resistance rating.

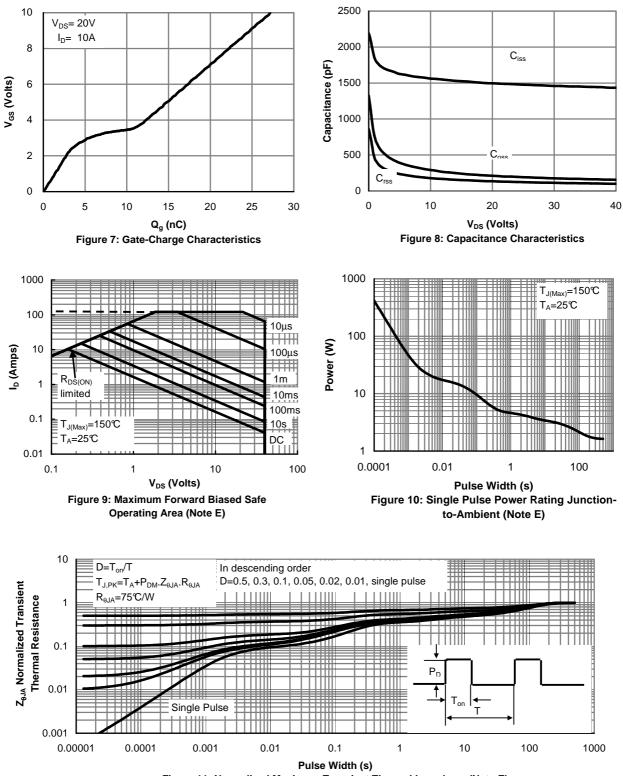
G. E_{AR} and I_{AR} ratings are based on low frequency and duty cycles to keep T_j =25C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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Figure 11: Normalized Maximum Transient Thermal Impedance(Note E)

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